

# S-5741 B Series

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# 125°C OPERATION HIGH-WITHSTAND VOLTAGE HIGH-SPEED BIPOLAR HALL EFFECT LATCH IC

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This IC, developed by CMOS technology, is a bipolar Hall effect latch IC with high-withstand voltage, high-speed detection and high-accuracy magnetic characteristics.

The output voltage changes when this IC detects the intensity level of magnetic flux density and a polarity change. Using this IC with a magnet makes it possible to detect the rotation status in various devices. This IC includes an output current limit circuit

High-density mounting is possible by using the small SOT-23-3S package.

Due to its high-accuracy magnetic characteristics, this IC can make operation's dispersion in the system combined with magnet smaller.

ABLIC Inc. offers a "magnetic simulation service" that provides the ideal combination of magnets and our Hall effect ICs for customer systems. Our magnetic simulation service will reduce prototype production, development period and development costs. In addition, it will contribute to optimization of parts to realize high cost performance.

For more information regarding our magnetic simulation service, contact our sales representatives.

#### ■ Features

• Pole detection: Bipolar latch

• Output logic\*1: Vout = "L" at S pole detection

V<sub>OUT</sub> = "H" at S pole detection

• Output form\*1: Nch open-drain output

Nch driver + built-in pull-up resistor

• Magnetic sensitivity\*1:  $B_{OP} = 1.8 \text{ mT typ.}$ 

 $B_{OP} = 3.0 \text{ mT typ.}$   $B_{OP} = 6.0 \text{ mT typ.}$  $f_C = 500 \text{ kHz typ.}$ 

• Output delay time:  $t_D$  = 8.0  $\mu$ s typ. • Power supply voltage range:  $V_{DD}$  = 3.5 V to 26.0 V

• Built-in regulator

• Chopping frequency:

• Built-in output current limit circuit

• Operation temperature range: Ta =  $-40^{\circ}$ C to  $+125^{\circ}$ C

• Lead-free (Sn 100%), halogen-free

# ■ Applications

- Home appliance
- DC brushless motor
- Housing equipment
- Industrial equipment

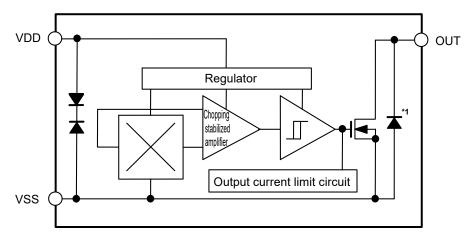
#### ■ Package

• SOT-23-3S

**<sup>\*1.</sup>** The option can be selected.

# **■** Block Diagrams

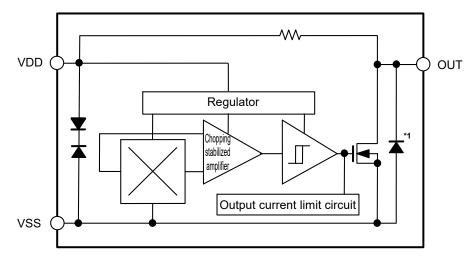
# 1. Nch open-drain output product



\*1. Parasitic diode

Figure 1

# 2. Nch driver + built-in pull-up resistor product



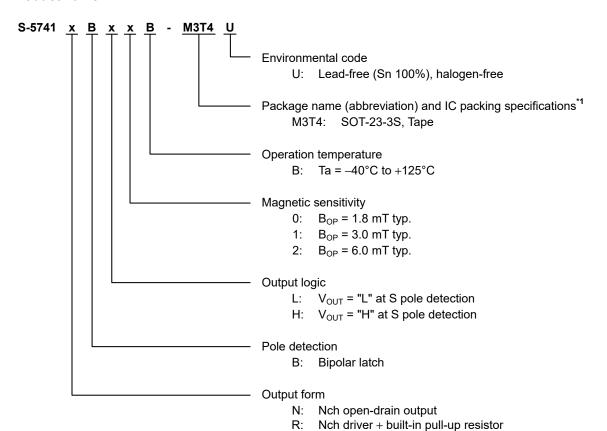
\*1. Parasitic diode

Figure 2

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#### **■ Product Name Structure**

#### 1. Product name



<sup>\*1.</sup> Refer to the tape drawing.

# 2. Package

**Table 1 Package Drawing Codes** 

| Package Name | Dimension    | Tape         | Reel         |  |
|--------------|--------------|--------------|--------------|--|
| SOT-23-3S    | MP003-D-P-SD | MP003-D-C-SD | MP003-D-R-SD |  |

## 3. Product name list

#### Table 2

| Product Name      | Output Form                            | Pole<br>Detection | Output logic                               | Magnetic<br>Sensitivity<br>(Bo <sub>P</sub> ) |
|-------------------|--|-------------------|--|---|
| S-5741NBL0B-M3T4U | Nch open-drain output                  | Bipolar latch     | V <sub>OUT</sub> = "L" at S pole detection | 1.8 mT typ.                                   |
| S-5741NBL1B-M3T4U | Nch open-drain output                  | Bipolar latch     | V <sub>OUT</sub> = "L" at S pole detection | 3.0 mT typ.                                   |
| S-5741NBL2B-M3T4U | Nch open-drain output                  | Bipolar latch     | V <sub>OUT</sub> = "L" at S pole detection | 6.0 mT typ.                                   |
| S-5741NBH1B-M3T4U | Nch open-drain output                  | Bipolar latch     | V <sub>OUT</sub> = "H" at S pole detection | 3.0 mT typ.                                   |
| S-5741RBL0B-M3T4U | Nch driver + built-in pull-up resistor | Bipolar latch     | V <sub>OUT</sub> = "L" at S pole detection | 1.8 mT typ.                                   |
| S-5741RBL1B-M3T4U | Nch driver + built-in pull-up resistor | Bipolar latch     | V <sub>OUT</sub> = "L" at S pole detection | 3.0 mT typ.                                   |
| S-5741RBL2B-M3T4U | Nch driver + built-in pull-up resistor | Bipolar latch     | V <sub>OUT</sub> = "L" at S pole detection | 6.0 mT typ.                                   |
| S-5741RBH0B-M3T4U | Nch driver + built-in pull-up resistor | Bipolar latch     | V <sub>OUT</sub> = "H" at S pole detection | 1.8 mT typ.                                   |
| S-5741RBH1B-M3T4U | Nch driver + built-in pull-up resistor | Bipolar latch     | V <sub>OUT</sub> = "H" at S pole detection | 3.0 mT typ.                                   |
| S-5741RBH2B-M3T4U | Nch driver + built-in pull-up resistor | Bipolar latch     | V <sub>OUT</sub> = "H" at S pole detection | 6.0 mT typ.                                   |

**Remark** Please contact our sales representatives for products other than the above.

# **■** Pin Configuration

#### 1. SOT-23-3S

Top view



Pin No. Symbol Description

1 VSS GND pin

 1
 VSS
 GND pin

 2
 VDD
 Power supply pin

 3
 OUT
 Output pin

Table 3

Figure 3

# ■ Absolute Maximum Ratings

#### Table 4

(Ta = +25°C unless otherwise specified)

|                               | Item   | Symbol           | Absolute Maximum Rating           | Unit |
|-------------------------------|--|------------------|-----------------------------------|------|
| Power supply voltage          |  | V <sub>DD</sub>  | $V_{SS} - 0.3$ to $V_{SS} + 28.0$ | V    |
| Output current                |  | Іоит             | 20                                | mA   |
| Output valtage                | Nch open-drain output product                  | Vouт             | $V_{SS}-0.3$ to $V_{SS}+28.0$     | V    |
| Output voltage                | Nch driver + built-in pull-up resistor product | VOUT             | $V_{SS}-0.3$ to $V_{DD}+0.3$      | V    |
| Operation ambient temperature |  | T <sub>opr</sub> | -40 to +125                       | °C   |
| Storage temperature           |  | T <sub>stg</sub> | -40 to +150                       | °C   |

Caution The absolute maximum ratings are rated values exceeding which the product could suffer physical damage. These values must therefore not be exceeded under any conditions.

## ■ Thermal Resistance Value

Table 5

| Item                                     | Symbol | Condition |         | Min. | Тур. | Max. | Unit |
|--|--------|-----------|---------|------|------|------|------|
|  | θја    |           | Board A | 1    | 200  | 1    | °C/W |
|  |        | SOT-23-3S | Board B | I    | 165  | I    | °C/W |
| Junction-to-ambient thermal resistance*1 |        |           | Board C | I    | ı    | I    | °C/W |
|  |        |           | Board D | I    | ı    | I    | °C/W |
|  |        |           | Board E | ı    | ı    | ı    | °C/W |

<sup>\*1.</sup> Test environment: compliance with JEDEC STANDARD JESD51-2A

Remark Refer to "■ Power Dissipation" and "Test Board" for details.

## **■** Electrical Characteristics

Table 6
(Ta = +25°C, Vpp = 12.0 V, Vss = 0 V unless otherwise specified)

| Item                 | Symbol          | Condition  | Min. | Тур. | Max. | Unit | Test<br>Circuit |
|----------------------|-----------------|--|------|------|------|------|-----------------|
| Power supply voltage | $V_{DD}$        | I  | 3.5  | 12.0 | 26.0 | V    | _               |
| Current consumption  |                 | Nch open-drain output product Average value  | _    | 3.0  | 4.0  | mA   | 1               |
| Current consumption  | I <sub>DD</sub> | Nch driver + built-in pull-up resistor product Average value, V <sub>OUT</sub> = "H"                                   | _    | 3.0  | 4.0  | mA   | 1               |
| Output voltage       | V               | Nch open-drain output product Output transistor Nch, V <sub>OUT</sub> = "L", I <sub>OUT</sub> = 10 mA                  | _    | _    | 0.4  | V    | 2               |
| Output voltage VouT  |                 | Nch driver + built-in pull-up resistor product Output transistor Nch, V <sub>OUT</sub> = "L", I <sub>OUT</sub> = 10 mA | _    | _    | 0.5  | V    | 2               |
| Output drop voltage  | VD              | Nch driver + built-in pull-up resistor product $V_{OUT}$ = "H", $V_D$ = $V_{DD}$ - $V_{OUT}$                           | _    | _    | 20   | mV   | 2               |
| Leakage current      | ILEAK           | Nch open-drain output product Output transistor Nch, V <sub>OUT</sub> = "H" = 26.0 V                                   | _    | _    | 10   | μΑ   | 3               |
| Output limit current | I <sub>OM</sub> | V <sub>OUT</sub> = 12.0 V  | 22   | _    | 70   | mA   | 3               |
| Output delay time    | t <sub>D</sub>  | -  | _    | 8.0  | _    | μs   | _               |
| Chopping frequency   | fc              | <del>-</del>   | _    | 500  | _    | kHz  | _               |
| Start up time        | tpon            | 1  | _    | 20   | _    | μs   | 4               |
|                      | 4_              | Nch open-drain output product $C = 20 \text{ pF}, R = 820 \Omega$  | _    | _    | 2.0  | μs   | 5               |
|                      | t <sub>R</sub>  | Nch driver + built-in pull-up resistor product<br>C = 20 pF  | _    | _    | 6.0  | μs   | 5               |
| Output fall time     | t <sub>F</sub>  | C = 20 pF, R = 820 $\Omega$  | _    | _    | 2.0  | μs   | 5               |
| Pull-up resistor     | R∟              | Nch driver + built-in pull-up resistor product   | 7    | 10   | 13   | kΩ   | _               |

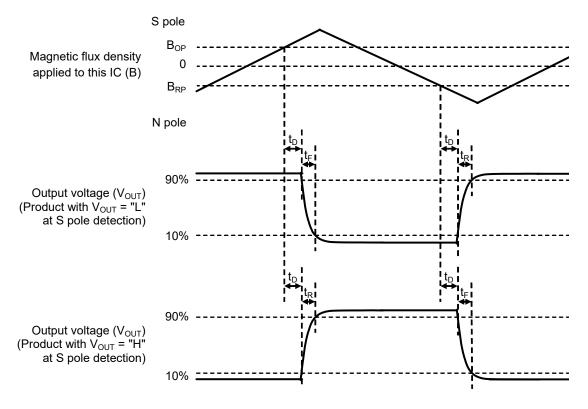


Figure 4 Operation Timing

# ■ Magnetic Characteristics

## 1. Product with $B_{OP} = 1.8 \text{ mT typ.}$

Table 7

(Ta = +25°C, V<sub>DD</sub> = 12.0 V, V<sub>SS</sub> = 0 V unless otherwise specified)

|                    |        |                   | (  | -, -55 | ,    |      |      |              |
|--------------------|--------|-------------------|--|--------|------|------|------|--------------|
| Item               |        | Symbol            | Condition  | Min.   | Тур. | Max. | Unit | Test Circuit |
| Operation point*1  | S pole | Вор               | _  | 0.3    | 1.8  | 3.3  | mT   | 4            |
| Release point*2    | N pole | B <sub>RP</sub>   | _  | -3.3   | -1.8 | -0.3 | mT   | 4            |
| Hysteresis width*3 |        | B <sub>H</sub> ys | B <sub>HYS</sub> = B <sub>OP</sub> - B <sub>RP</sub> | _      | 3.6  | _    | mT   | 4            |

#### 2. Product with $B_{OP} = 3.0 \text{ mT typ.}$

#### Table 8

(Ta = +25°C, V<sub>DD</sub> = 12.0 V, V<sub>SS</sub> = 0 V unless otherwise specified)

| Item               |        | Symbol           | Condition  | Min. | Тур. | Max. | Unit | Test Circuit |
|--------------------|--------|------------------|--|------|------|------|------|--------------|
| Operation point*1  | S pole | BOP              | -  | 1.5  | 3.0  | 4.5  | mT   | 4            |
| Release point*2    | N pole | B <sub>RP</sub>  | _  | -4.5 | -3.0 | -1.5 | mT   | 4            |
| Hysteresis width*3 |        | B <sub>HYS</sub> | B <sub>HYS</sub> = B <sub>OP</sub> - B <sub>RP</sub> | _    | 6.0  | _    | mT   | 4            |

# 3. Product with $B_{OP} = 6.0 \text{ mT typ.}$

#### Table 9

(Ta = +25°C, V<sub>DD</sub> = 12.0 V, V<sub>SS</sub> = 0 V unless otherwise specified)

| Item               |        | Symbol           | Condition  | Min. | Тур. | Max. | Unit | Test Circuit |
|--------------------|--------|------------------|--|------|------|------|------|--------------|
| Operation point*1  | S pole | BOP              | _  | 3.0  | 6.0  | 9.0  | mT   | 4            |
| Release point*2    | N pole | B <sub>RP</sub>  | _  | -9.0 | -6.0 | -3.0 | mT   | 4            |
| Hysteresis width*3 |        | B <sub>HYS</sub> | B <sub>HYS</sub> = B <sub>OP</sub> - B <sub>RP</sub> | _    | 12.0 | _    | mT   | 4            |

<sup>\*1.</sup> B<sub>OP</sub>: Operation point

 $B_{OP}$  is the value of magnetic flux density when the output voltage ( $V_{OUT}$ ) changes after the magnetic flux density applied to this IC by the magnet (S pole) is increased (by moving the magnet closer).

V<sub>OUT</sub> retains the status until a magnetic flux density of the N pole higher than B<sub>RP</sub> is applied.

#### \*2. BRP: Release point

 $B_{RP}$  is the value of magnetic flux density when the output voltage ( $V_{OUT}$ ) changes after the magnetic flux density applied to this IC by the magnet (N pole) is increased (by moving the magnet closer).

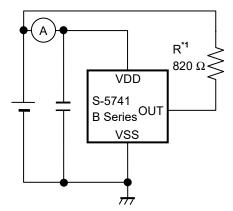
V<sub>OUT</sub> retains the status until a magnetic flux density of the S pole higher than B<sub>OP</sub> is applied.

B<sub>HYS</sub> is the difference of magnetic flux density between B<sub>OP</sub> and B<sub>RP</sub>.

**Remark** The unit of magnetic flux density mT can be converted by using the formula 1 mT = 10 Gauss.

<sup>\*3.</sup> B<sub>HYS</sub>: Hysteresis width

## **■ Test Circuits**



\*1. Resistor (R) is unnecessary for Nch driver + built-in pull-up resistor product.

Figure 5 Test Circuit 1

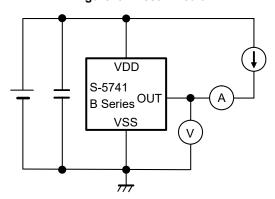


Figure 6 Test Circuit 2

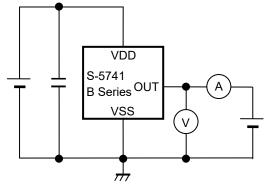
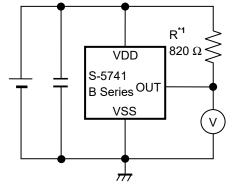
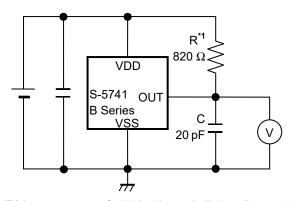


Figure 7 Test Circuit 3



**\*1.** Resistor (R) is unnecessary for Nch driver + built-in pull-up resistor product.

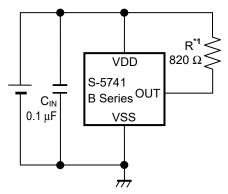
Figure 8 Test Circuit 4



**\*1.** Resistor (R) is unnecessary for Nch driver + built-in pull-up resistor product.

Figure 9 Test Circuit 5

# ■ Standard Circuit



\*1. Resistor (R) is unnecessary for Nch driver + built-in pull-up resistor product.

Figure 10

Caution The above connection diagram and constant will not guarantee successful operation. Perform thorough evaluation using the actual application to set the constant.

# ■ Operation

## 1. Direction of applied magnetic flux

This IC detects the magnetic flux density which is vertical to the marking surface. **Figure 11** shows the direction in which magnetic flux is being applied.

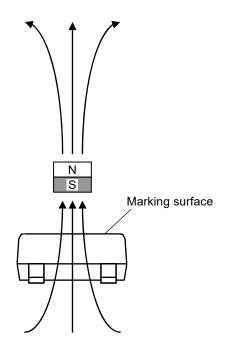


Figure 11

#### 2. Position of Hall sensor

Figure 12 shows the position of Hall sensor.

The center of this Hall sensor is located in the area indicated by a circle, which is in the center of a package as described below.

The following also shows the distance (typ. value) between the marking surface and the chip surface of a package.

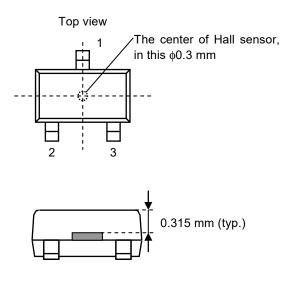


Figure 12

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#### 3. Basic operation

This IC changes the output voltage (V<sub>OUT</sub>) according to the level of the magnetic flux density and a polarity change (N pole or S pole) applied by a magnet.

#### 3. 1 Product with Vout = "L" at S pole detection

When the magnetic flux density of the S pole perpendicular to the marking surface exceeds the operation point ( $B_{OP}$ ) after the S pole of a magnet is moved closer to the marking surface of this IC,  $V_{OUT}$  changes from "H" to "L". When the N pole of a magnet is moved closer to the marking surface of this IC and the magnetic flux density of the N pole is higher than the release point ( $B_{RP}$ ),  $V_{OUT}$  changes from "L" to "H". In case of  $B_{RP} < B < B_{OP}$ ,  $V_{OUT}$  retains the status. **Figure 13** shows the relationship between the magnetic flux density and  $V_{OUT}$ .

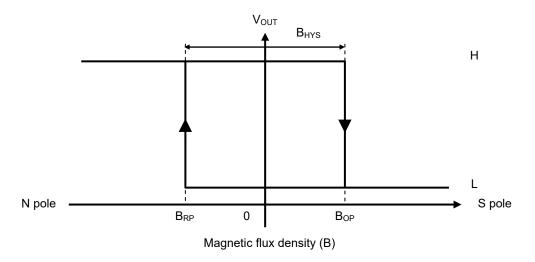


Figure 13

### 3. 2 Product with Vout = "H" at S pole detection

When the magnetic flux density of the S pole perpendicular to the marking surface exceeds  $B_{OP}$  after the S pole of a magnet is moved closer to the marking surface of this IC,  $V_{OUT}$  changes from "L" to "H". When the N pole of a magnet is moved closer to the marking surface of this IC and the magnetic flux density of the N pole is higher than  $B_{RP}$ ,  $V_{OUT}$  changes from "H" to "L". In case of  $B_{RP} < B < B_{OP}$ ,  $V_{OUT}$  retains the status.

Figure 14 shows the relationship between the magnetic flux density and Vout.

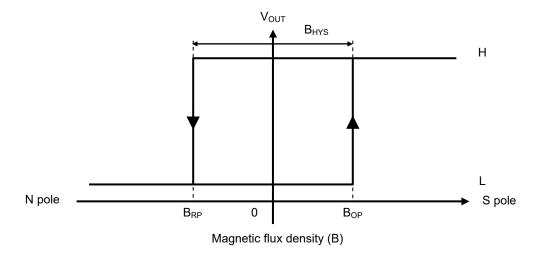


Figure 14

## 4. Timing chart

Figure 15 shows the operation timing at power-on.

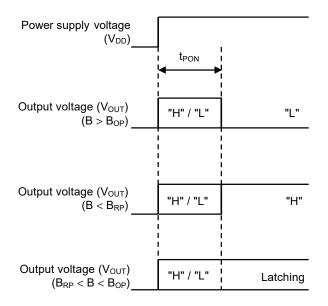
The initial output voltage at rising of power supply voltage (VDD) is either "H" or "L".

In case of B > B<sub>OP</sub> (operation point) or B < B<sub>RP</sub> (release point) at the time when the start up time (t<sub>PON</sub>) is passed after rising of  $V_{DD}$ , this IC outputs  $V_{OUT}$  according to the applied magnetic flux density.

In case of  $B_{RP} < B < B_{OP}$  at the time when  $t_{PON}$  is passed after rising of  $V_{DD}$ , this IC maintains the initial output voltage.

## Product with V<sub>OUT</sub> = "L" at S pole detection

#### Product with V<sub>OUT</sub> = "H" at S pole detection



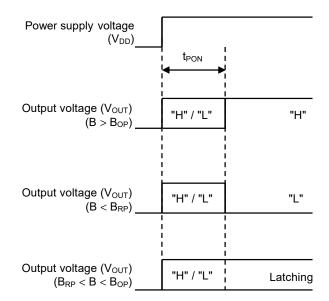


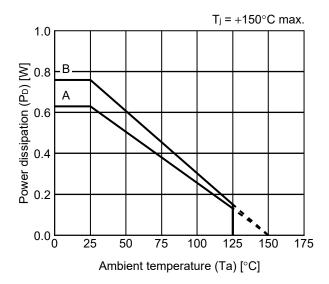
Figure 15

#### ■ Precautions

- If the impedance of the power supply is high, the IC may malfunction due to a supply voltage drop caused by feed-through current. Take care with the pattern wiring to ensure that the impedance of the power supply is low.
- Note that the IC may malfunction if the power supply voltage rapidly changes. When the IC is used under the
  environment where the power supply voltage rapidly changes, it is recommended to judge the output voltage of the IC
  by reading it multiple times.
- Do not apply an electrostatic discharge to this IC that exceeds the performance ratings of the built-in electrostatic protection circuit.
- Although this IC has a built-in output current limit circuit, it may suffer physical damage such as product deterioration under the environment where the absolute maximum ratings are exceeded.
- The application conditions for the power supply voltage, the pull-up voltage, and the pull-up resistor should not exceed the power dissipation.
- Large stress on this IC may affect the magnetic characteristics. Avoid large stress which is caused by the handling during or after mounting the IC on a board.
- ABLIC Inc. claims no responsibility for any disputes arising out of or in connection with any infringement by products including this IC of patents owned by a third party.

# **■ Power Dissipation**

# **SOT-23-3S**

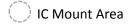


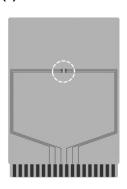
| Board | Power Dissipation (P <sub>D</sub> ) |
|-------|-------------------------------------|
| Α     | 0.63 W                              |
| В     | 0.76 W                              |
| С     | _                                   |
| D     | _                                   |
| Е     | _                                   |

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# **SOT-23-3/3S/5/6** Test Board

# (1) Board A





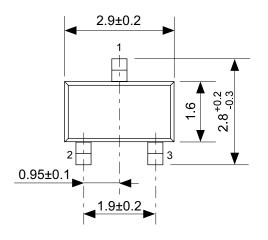
| Item                        |   | Specification                               |
|-----------------------------|---|---|
| Size [mm]                   |   | 114.3 x 76.2 x t1.6                         |
| Material                    |   | FR-4  |
| Number of copper foil layer |   | 2   |
|                             | 1 | Land pattern and wiring for testing: t0.070 |
| Coppor foil lover [mm]      | 2 | -   |
| Copper foil layer [mm]      | 3 | -   |
|                             | 4 | 74.2 x 74.2 x t0.070                        |
| Thermal via                 |   | -   |

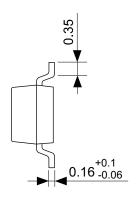
# (2) Board B

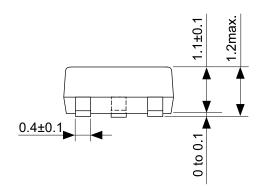


| Item                        |   | Specification                               |
|-----------------------------|---|---|
| Size [mm]                   |   | 114.3 x 76.2 x t1.6                         |
| Material                    |   | FR-4  |
| Number of copper foil layer |   | 4   |
|                             | 1 | Land pattern and wiring for testing: t0.070 |
| Copper foil layer [mm]      | 2 | 74.2 x 74.2 x t0.035                        |
| Copper foil layer [min]     | 3 | 74.2 x 74.2 x t0.035                        |
|                             | 4 | 74.2 x 74.2 x t0.070                        |
| Thermal via                 |   | -   |

No. SOT23x-A-Board-SD-2.0

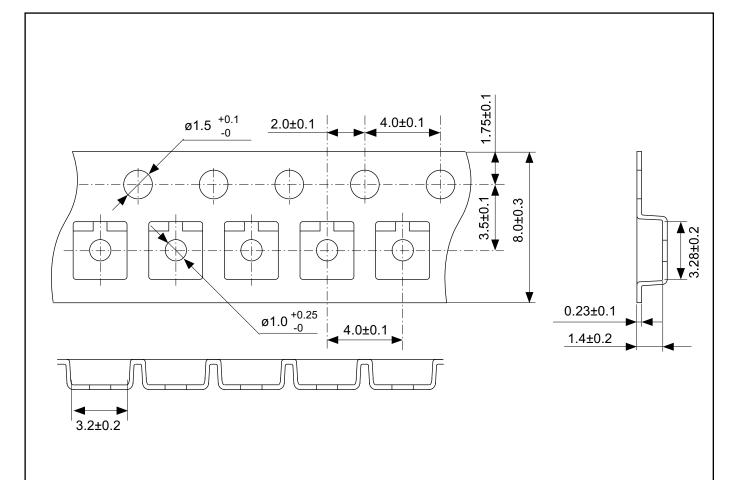


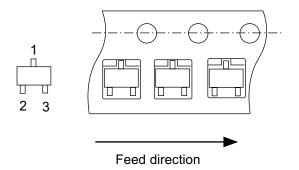




# No. MP003-D-P-SD-1.1

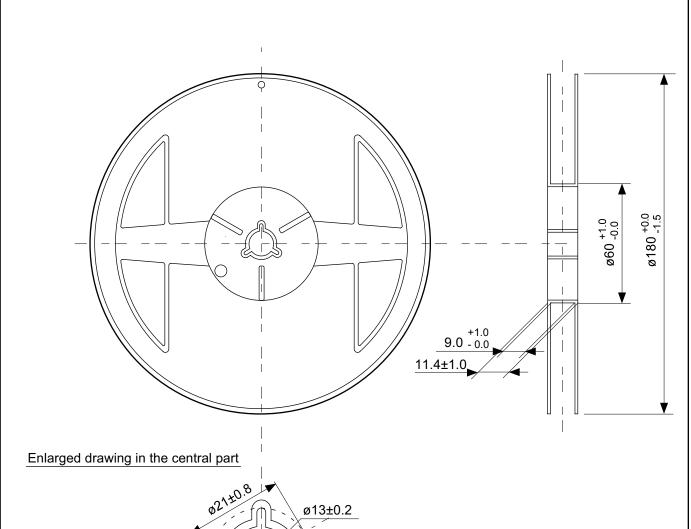
| TITLE      | SOT233S-A-PKG Dimensions |  |  |  |
|------------|--------------------------|--|--|--|
| No.        | MP003-D-P-SD-1.1         |  |  |  |
| ANGLE      | <b>\$</b>                |  |  |  |
| UNIT       | mm                       |  |  |  |
|            |                          |  |  |  |
|            |                          |  |  |  |
|            |                          |  |  |  |
| ABUIOI     |                          |  |  |  |
| ABLIC Inc. |                          |  |  |  |

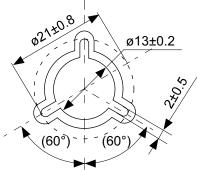




# No. MP003-D-C-SD-1.0

| TITLE      | SOT233S-A-Carrier Tape |  |  |  |
|------------|------------------------|--|--|--|
| No.        | MP003-D-C-SD-1.0       |  |  |  |
| ANGLE      |                        |  |  |  |
| UNIT       | mm                     |  |  |  |
|            |                        |  |  |  |
|            |                        |  |  |  |
|            |                        |  |  |  |
| ABLIC Inc. |                        |  |  |  |





# No. MP003-D-R-SD-1.0

| TITLE      | SOT233S-A-Reel   |      |       |  |
|------------|------------------|------|-------|--|
| No.        | MP003-D-R-SD-1.0 |      |       |  |
| ANGLE      |                  | QTY. | 3,000 |  |
| UNIT       | mm               |      |       |  |
|            |                  |      |       |  |
|            |                  |      |       |  |
|            |                  |      |       |  |
| ABLIC Inc. |                  |      |       |  |

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